

RoHS Compliant Product
A suffix of "-C" specifies halogen and lead-free

DESCRIPTION

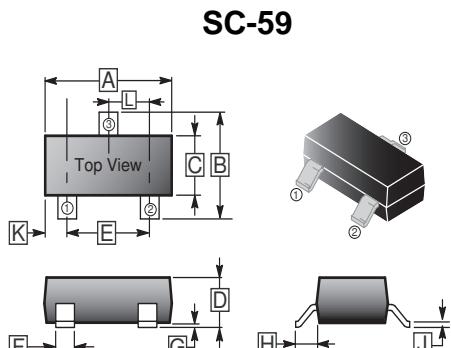
These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $R_{DS(ON)}$ and to ensure minimal power loss and heat dissipation.

FEATURES

- Low $R_{DS(on)}$ provides higher efficiency and extends battery life.
- Low thermal impedance copper leadframe SC59 saves board space.
- Fast switching speed.
- High performance trench technology.

APPLICATION

DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

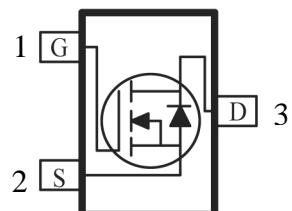


REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	0.10	REF.
B	2.25	3.00	H	0.40	REF.
C	1.30	1.70	J	0.10	0.20
D	1.00	1.40	K	0.45	0.55
E	1.70	2.30	L	0.85	1.15
F	0.35	0.50			

PACKAGE INFORMATION

Package	MPQ	Leader Size
SC-59	3K	7 inch

TOP VIEW



ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Ratings		Unit	
Drain-Source Voltage	V_{DS}	30		V	
Gate-Source Voltage	V_{GS}	± 20		V	
Continuous Drain Current ¹	I_D	2.0		A	
		1.7		A	
Pulsed Drain Current ²	I_{DM}	± 20		A	
Continuous Source Current (Diode Conduction) ¹	I_S	1.6		A	
Power Dissipation ¹	P_D	0.34		W	
		0.22		W	
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150		°C	
Thermal Resistance Ratings					
Maximum Junction to Ambient ¹	$t \leq 5 \text{ sec}$	$R_{\theta JA}$	100	°C / W	
	Steady State		166		

Notes:

1 Surface Mounted on 1" x 1" FR4 Board.

2 Pulse width limited by maximum junction temperature.

ELECTRICAL CHARACTERISTICS ($T_A=25^\circ C$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Gate-Threshold Voltage	$V_{GS(th)}$	1	-	-	V	$V_{DS}=V_{GS}$, $I_D=250\mu A$
Gate-Body Leakage	I_{GSS}	-	-	± 100	nA	$V_{DS}=0$, $V_{GS} = \pm 20V$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$V_{DS}=24V$, $V_{GS}=0$
		-	-	10		$V_{DS}=24V$, $V_{GS}=0$, $T_J=55^\circ C$
On-State Drain Current ¹	$I_{D(on)}$	10	-	-	A	$V_{DS}=5V$, $V_{GS}=10V$
Drain-Source On-Resistance ¹	$R_{DS(ON)}$	-	-	58	$m\Omega$	$V_{GS}=10V$, $I_D=2A$
		-	-	82		$V_{GS}=4.5V$, $I_D=1.7A$
Forward Transconductance ¹	g_{fs}	-	11.3	-	S	$V_{DS}=10V$, $I_D=2A$
Diode Forward Voltage	V_{SD}	-	0.75	-	V	$I_S=1.6A$, $V_{GS}=0$
Dynamic ²						
Total Gate Charge	Q_g	-	7.5	-	nC	$V_{DS}=10V$, $V_{GS}=5V$, $I_D=2A$
Gate-Source Charge	Q_{gs}	-	0.6	-		
Gate-Drain Charge	Q_{gd}	-	1	-		
Turn-on Delay Time	$T_{d(on)}$	-	8	-	nS	$V_{DD}=10V$, $V_{GEN}=4.5V$, $R_L=15\Omega$, $I_D=1A$
Rise Time	T_r	-	24	-		
Turn-off Delay Time	$T_{d(off)}$	-	35	-		
Fall Time	T_f	-	10	-		

Notes:

1 Pulse test : PW \leq 300 μs duty cycle \leq 2%.

2 Guaranteed by design, not subject to production testing.